

# TS3L110 Quad SPDT High-Bandwidth 10/100 Base-T LAN Switch

## Differential 8-Channel to 4-Channel Multiplexer/Demultiplexer

### 1 Features

- Wide bandwidth (BW = 500 MHz typical)
- Low crosstalk ( $X_{TALK} = -30$  dB typical)
- Bidirectional data flow with near-zero propagation delay
- Low and flat ON-state resistance ( $r_{on} = 4\ \Omega$  typical,  $r_{on(Flat)} = 1\ \Omega$ )
- Switching on Data I/O Ports (0 to 5 V)
- $V_{CC}$  Operating range from 3 V to 3.6 V
- $I_{off}$  Supports partial power-down-mode operation
- Data and control inputs have undershoot clamp diodes
- Latch-up performance exceeds 100 mA Per JESD 78, class II
- ESD Performance tested per JESD 22
  - 2000-V Human-body model (A114-B, class II)
  - 1000-V Charged-device model (C101)
- Suitable for both 10 Base-T and 100 Base-T signaling

### 2 Applications

- 10 and 100 Base-T signal switching

### 3 Description

The TS3L110 local area network (LAN) switch is a 4-bit 1-of-2 multiplexer/demultiplexer with a single switch-enable ( $\bar{E}$ ) input. When  $\bar{E}$  is low, the switch is enabled, and the I port is connected to the Y port. When  $\bar{E}$  is high, the switch is disabled, and the high-impedance state exists between the I and Y ports. The select (S) input controls the data path of the multiplexer/demultiplexer.

The TS3L110 device can be used to replace mechanical relays in LAN applications. This device has low and flat ON-state resistance ( $r_{on}$ ), wide bandwidth, and low crosstalk, making it suitable for 10/100 Base-T and various other LAN applications. The TS3L110 device can be used to route signals from a 10/100 Base-T Ethernet transceiver to the RJ-45 LAN connectors in laptops or in docking stations. This device is designed for low channel-to-channel skew and low crosstalk.

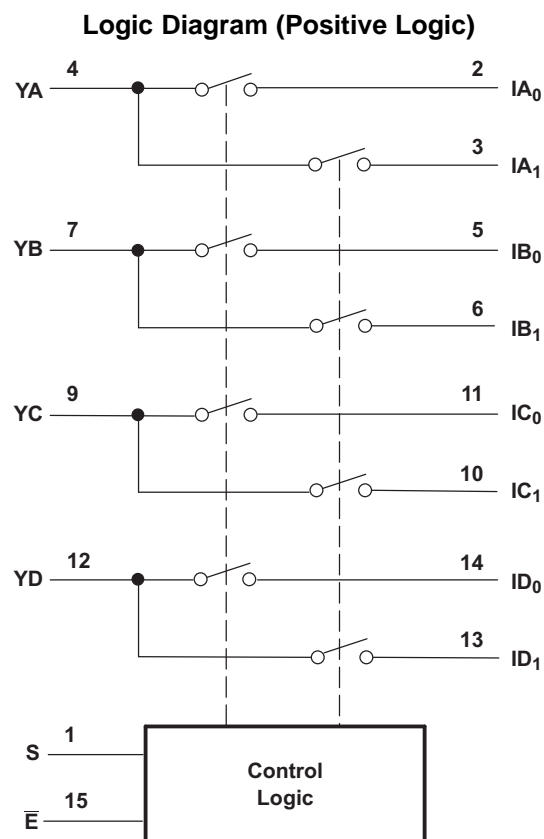
This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  feature ensures that damaging current does not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down,  $\bar{E}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TS3L110	SOIC (D) 16	9.90 mm x 3.91 mm
	SSOP (DBQ) 16	4.90 mm x 3.90 mm
	TVSOP (DGV) 16	3.60 mm x 4.40 mm
	TSSOP (PW) 16	5.00 mm x 4.40 mm
	VQFN (RGV) 16	4.00 mm x 4.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



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## 4 Revision History

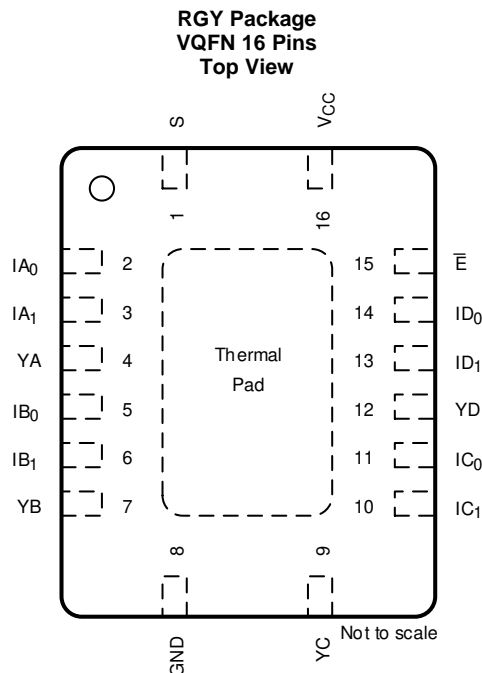
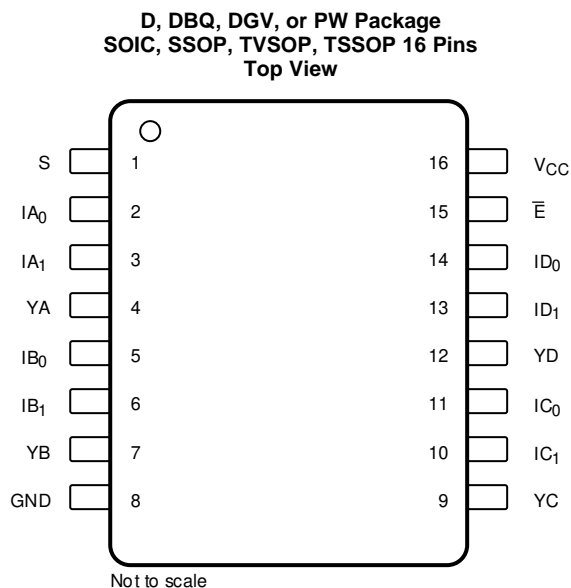
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (May 2019) to Revision B	Page
• Change pin 10 to IC <sub>1</sub> , pin 11 to IC <sub>0</sub> , pin 13 to ID <sub>1</sub> , and pin 14 to ID <sub>0</sub> in the <i>Pin Configuration and Functions</i> .....	<b>3</b>

Changes from Original (September 2004) to Revision A	Page
• Added <i>Device Information</i> table, <i>ESD Ratings</i> table, <i>Thermal Information</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section. ....	<b>1</b>

## 5 Pin Configuration and Functions



### Pin Functions

PIN		DESCRIPTION
NAME	NO.	
S	1	Select input
IA <sub>0</sub>	2	Data I/Os
IA <sub>1</sub>	3	Data I/Os
YA	4	Data I/Os
IB <sub>0</sub>	5	Data I/Os
IB <sub>1</sub>	6	Data I/Os
YB	7	Data I/Os
GND	8	Ground (0 V) reference
YC	9	Data I/Os
IC <sub>1</sub>	10	Data I/Os
IC <sub>0</sub>	11	Data I/Os
YD	12	Data I/Os
ID <sub>1</sub>	13	Data I/Os
ID <sub>0</sub>	14	Data I/Os
$\bar{E}$	15	Enable input
V <sub>CC</sub>	16	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 $\mu$ F to 10 $\mu$ F between VDD and GND.

## 6 Specifications

### 6.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		–0.5	4.6	V
$V_{IN}$	Control input voltage range <sup>(2)(3)</sup>		–0.5	7	V
$V_{I/O}$	Switch I/O voltage range <sup>(2)(3)(4)</sup>		–0.5	7	V
$I_{IK}$	Control input clamp current	$V_{IN} < 0$		–50	mA
$I_{I/O}$	I/O port clamp current	$V_{I/O} < 0$		–50	mA
$I_{I/O}$	ON-state switch current <sup>(5)</sup>			±128	mA
	Continuous current through $V_{CC}$ or GND			±100	mA
$\theta_{JA}$	Package thermal impedance	D package <sup>(6)</sup>		73	°C/W
		DBQ package <sup>(6)</sup>		90	
		DGV package <sup>(6)</sup>		120	
		PW package <sup>(6)</sup>		108	
		RGY package <sup>(7)</sup>		39	
$T_{stg}$	Storage temperature range		–65	150	°C

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4)  $V_I$  and  $V_O$  are used to denote specific conditions for  $V_{I/O}$ .
- (5)  $I_I$  and  $I_O$  are used to denote specific conditions for  $I_{I/O}$ .
- (6) The package thermal impedance is calculated in accordance with JESD 51-7.
- (7) The package thermal impedance is calculated in accordance with JESD 51-5.

### 6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 or ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. e.

### 6.3 Recommended Operating Conditions<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		3	3.6	V
$V_{IH}$	High-level control input voltage ( $\bar{E}$ , S)		2	5.5	V
$V_{IL}$	Low-level control input voltage ( $\bar{E}$ , S)		0	0.8	V
$V_{I/O}$	Input/output voltage		0	5.5	V
$T_A$	Operating free-air temperature		–40	85	°C

- (1) All unused control inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number [SCBA004](#).

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TS3L110					UNIT
		D (SOIC)	DBQ (SSOP)	DGV (TVSOP)	PW (TSSOP)	RGV (VQFN)	
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	92.0	114.5	139.3	111.5	50.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	52.3	60.5	57.4	42.0	48.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	50.3	58.2	73.7	57.8	26.7	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	17.3	15.3	7.2	4.2	2.1	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	50.0	57.6	73.0	57.2	26.5	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	-	-	-	-	10.7	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC package thermal metrics application report](#).

## 6.5 Electrical Characteristics<sup>(1)</sup>

over recommended operating free-air temperature range,  $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(2)</sup>	MAX	UNIT
$V_{IK}$	$\bar{E}$ , S	$V_{CC} = 3.6 \text{ V}$ ,	$I_{IN} = -18 \text{ mA}$			-1.8	V
$I_{IH}$	$\bar{E}$ , S	$V_{CC} = 3.6 \text{ V}$ ,	$V_{IN} = 5.5 \text{ V}$			±1	µA
$I_{IL}$	$\bar{E}$ , S	$V_{CC} = 3.6 \text{ V}$ ,	$V_{IN} = \text{GND}$			±1	µA
$I_{off}$		$V_{CC} = 0$ ,	$V_O = 0 \text{ to } 5.5 \text{ V}$ ,			1	µA
$I_{CC}$		$V_{CC} = 3.6 \text{ V}$ ,	$I_{IO} = 0$ ,		0.7	1.5	mA
$C_{in}$	$\bar{E}$ , S	$f = 1 \text{ MHz}$ ,	$V_{IN} = 0$		2.5	3.5	pF
$C_{io(OFF)}$	I port	$V_I = 0$ ,	$f = 1 \text{ MHz}$ , Outputs open,		3.5	5	pF
	Y port	$V_I = 0$ ,	$f = 1 \text{ MHz}$ , Outputs open,		5.5	7	
$C_{io(ON)}$	I or Y port	$V_I = 0$ ,	$f = 1 \text{ MHz}$ , Outputs open,		10.5	13	pF
$r_{on}$		$V_{CC} = 3 \text{ V}$ ,	$1.25 \text{ V} \leq V_I \leq V_{CC}$ ,		4	8	Ω
$r_{on(Flat)}^{(3)}$		$V_{CC} = 3 \text{ V}$ ,	$V_I = 1.25 \text{ V}$ and $V_{CC}$ ,		1		Ω
$\Delta r_{on}^{(4)}$		$V_{CC} = 3 \text{ V}$ ,	$1.25 \text{ V} \leq V_I \leq V_{CC}$ ,		0.9	2	Ω

- (1)  $V_I$ ,  $V_O$ ,  $I_I$ , and  $I_O$  refer to I/O pins.  $V_{IN}$  refers to the control inputs.  
(2) All typical values are at  $V_{CC} = 3.3 \text{ V}$  (unless otherwise noted),  $T_A = 25^\circ\text{C}$ .  
(3)  $r_{on(Flat)}$  is the difference of  $r_{on}$  in a given channel at specified voltages.  
(4)  $\Delta r_{on}$  is the difference of  $r_{on}$  in a given device.

## 6.6 Switching Characteristics

over recommended operating free-air temperature range,  $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ ,  $R_L = 200 \text{ } \Omega$ ,  $C_L = 10 \text{ pF}$   
(unless otherwise noted) (see [Figure 5](#) and [Figure 6](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP <sup>(1)</sup>	MAX	UNIT
$t_{pd}$ <sup>(2)</sup>	I or Y	Y or I		0.25		ns
$t_{PZH}$ , $t_{PZL}$	$\bar{E}$ or S	I or Y	0.5		7	ns
$t_{PHZ}$ , $t_{PLZ}$	$\bar{E}$ or S	I or Y	0.5		5	ns
$t_{sk(p)}$ <sup>(3)</sup>	I or Y	Y or I		0.1	0.2	ns

(1) All typical values are at  $V_{CC} = 3.3 \text{ V}$  (unless otherwise noted),  $T_A = 25^\circ\text{C}$ .

(2) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).

(3) Skew between opposite transitions of the same output  $|t_{PHL} - t_{PLH}|$ . This parameter is not production tested.

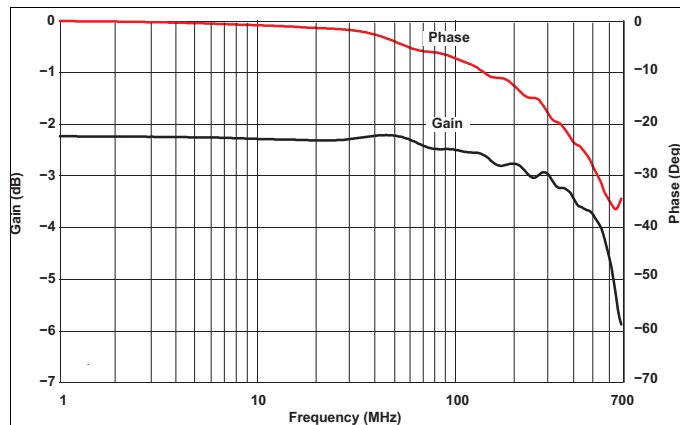
## 6.7 Dynamic Characteristics

over recommended operating free-air temperature range,  $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$  (unless otherwise noted)

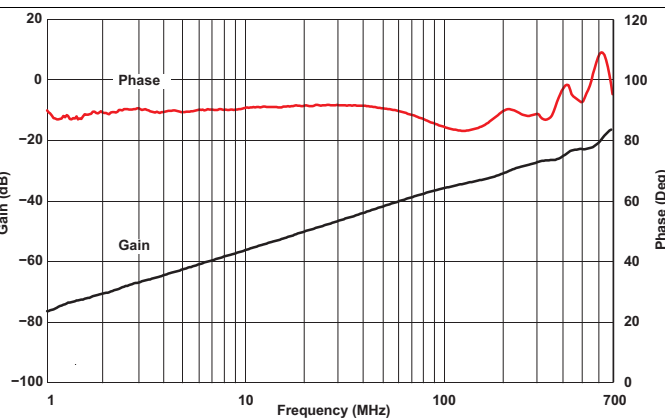
PARAMETER	TEST CONDITIONS			TYP <sup>(1)</sup>	UNIT
$X_{TALK}$	$R_L = 100 \text{ } \Omega$ ,	$f = 250 \text{ MHz}$ ,	See <a href="#">Figure 7</a>	–26	dB
$O_{IRR}$	$R_L = 100 \text{ } \Omega$ ,	$f = 250 \text{ MHz}$ ,	See <a href="#">Figure 8</a>	–28	dB
BW	$R_L = 100 \text{ } \Omega$ ,		See <a href="#">Figure 6</a>	500	MHz

(1) All typical values are at  $V_{CC} = 3.3 \text{ V}$  (unless otherwise noted),  $T_A = 25^\circ\text{C}$ .

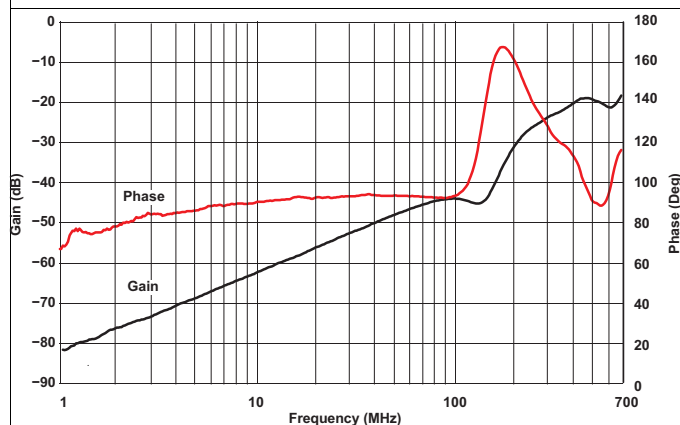
## 6.8 Typical Characteristics



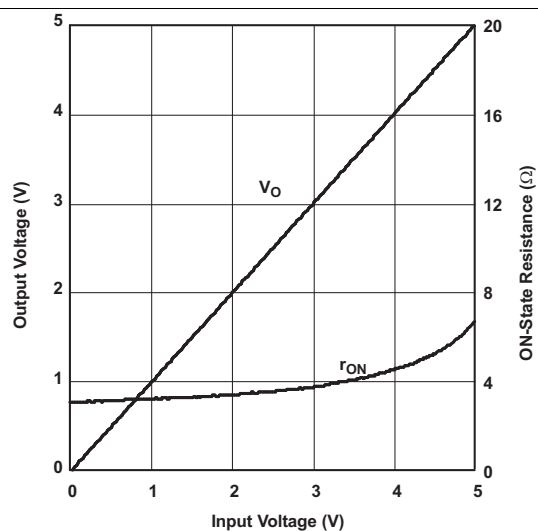
**Figure 1. Gain and Phase vs Frequency**



**Figure 2. OFF Isolation vs Frequency**

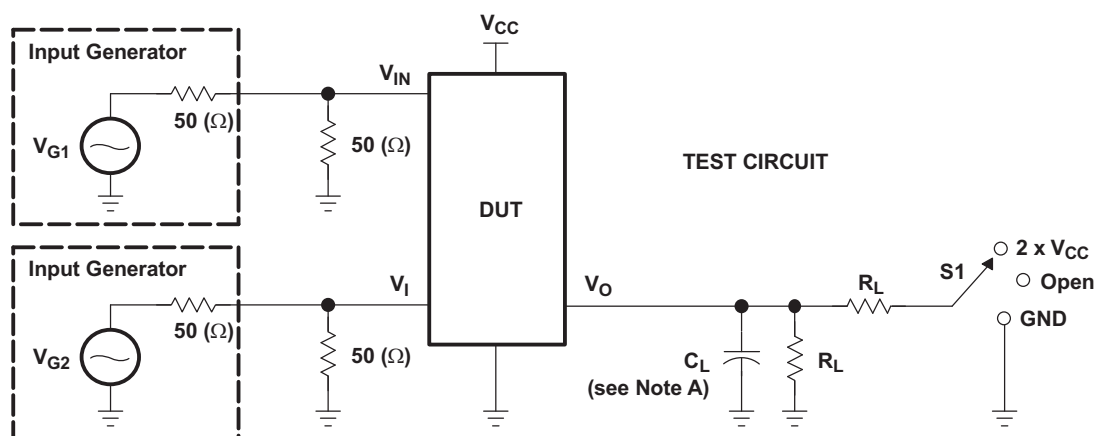


**Figure 3. Crosstalk vs Frequency**

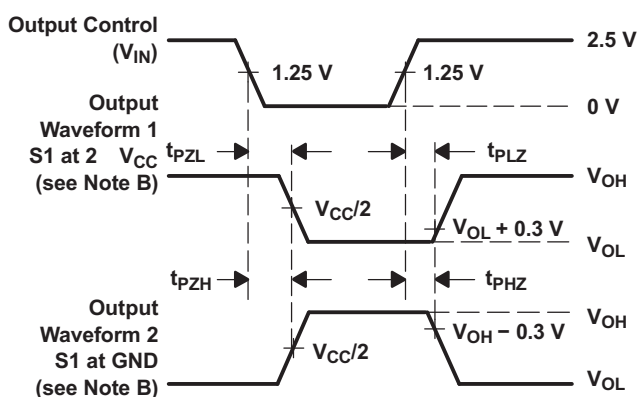


**Figure 4. Output Voltage and ON-State Resistance vs Input Voltage**

## 7 Parameter Measurement Information



TEST	V <sub>CC</sub>	S1	R <sub>L</sub>	V <sub>I</sub>	C <sub>L</sub>	V <sub>Δ</sub>
t <sub>PLZ</sub> /t <sub>PZL</sub>	3.3 V ± 0.3 V	2 x V <sub>CC</sub>	200 (Ω)	GND	10 pF	0.3 V
t <sub>PHZ</sub> /t <sub>PZH</sub>	3.3 V ± 0.3 V	GND	200 (Ω)	V <sub>CC</sub>	10 pF	0.3 V



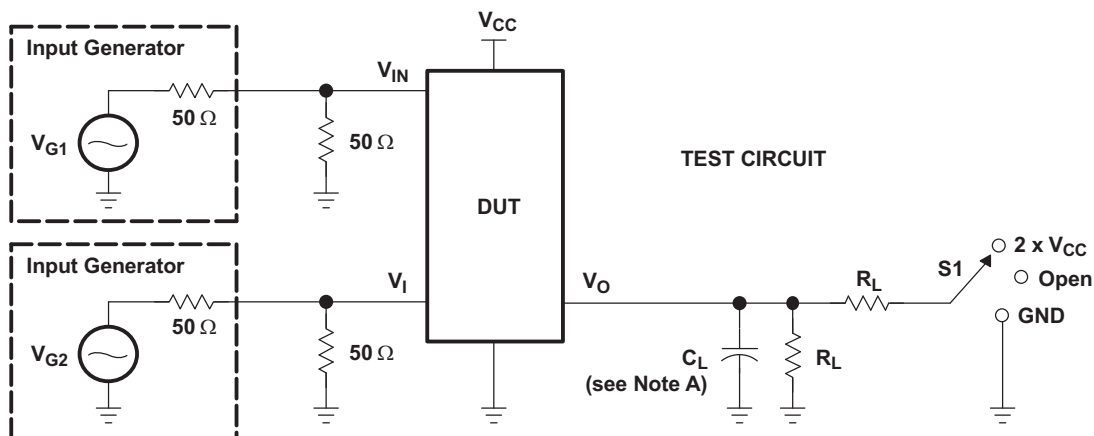
**VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES**

- A. C<sub>L</sub> includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω, t<sub>r</sub> ≤ 2.5 ns, t<sub>f</sub> ≤ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F. t<sub>PLZ</sub> and t<sub>PHH</sub> are the same as t<sub>en</sub>.

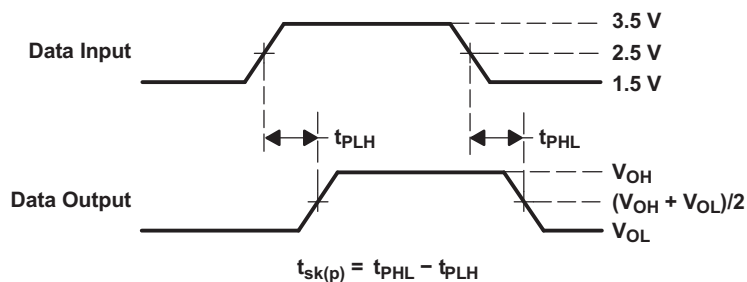
**Figure 5. Test Circuit and Voltage Waveforms**



## Parameter Measurement Information (continued)



TEST	V <sub>CC</sub>	S1	R <sub>L</sub>	V <sub>IN</sub> (see Note B)	C <sub>L</sub>
t <sub>sk(p)</sub>	3.3 V ± 0.3 V	GND	200 Ω	V <sub>CC</sub> or GND	10 pF

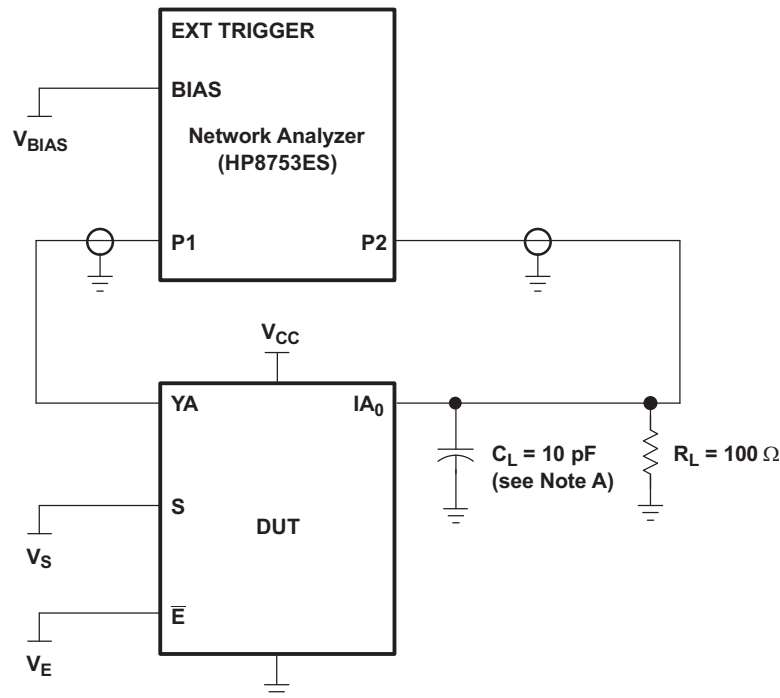


**VOLTAGE WAVEFORMS  
PULSE SKEW [t<sub>sk(p)</sub>]**

- A. C<sub>L</sub> includes probe and jig capacitance.
- B. Switch is ON during the measurement of t<sub>sk(p)</sub>, that is, voltage at E = 0 and S = V<sub>CC</sub> or GND.

**Figure 6. Test Circuit and Voltage Waveforms**

### Parameter Measurement Information (continued)



A.  $C_L$  includes probe and jig capacitance.

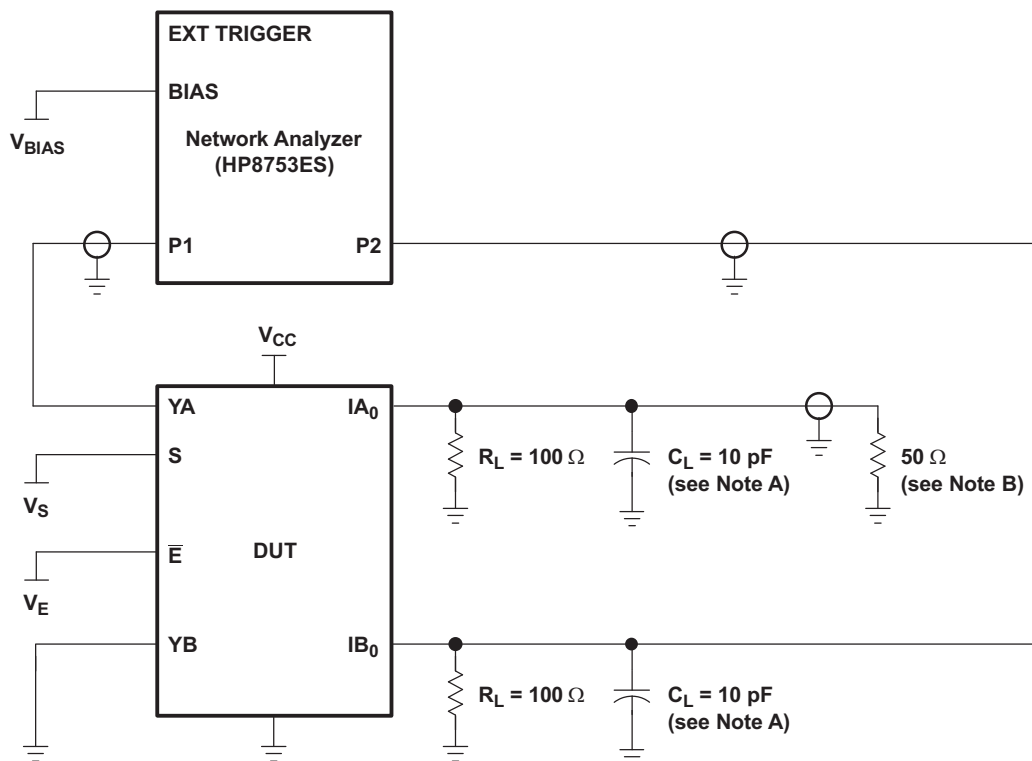
**Figure 7. Test Circuit for Frequency Response (BW)**

Frequency response is measured at the output of the ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at  $IA_0$ . All unused analog I/O ports are left open.

#### HP8753ES Setup

- Average = 4
- RBW = 3 kHz
- $V_{BIAS} = 0.35\text{ V}$
- ST = 2 s
- P1 = 0 dBm

### Parameter Measurement Information (continued)



- A.  $C_L$  includes probe and jig capacitance.  
B. A 50- $\Omega$  termination resistor is needed to match the loading of the network analyzer

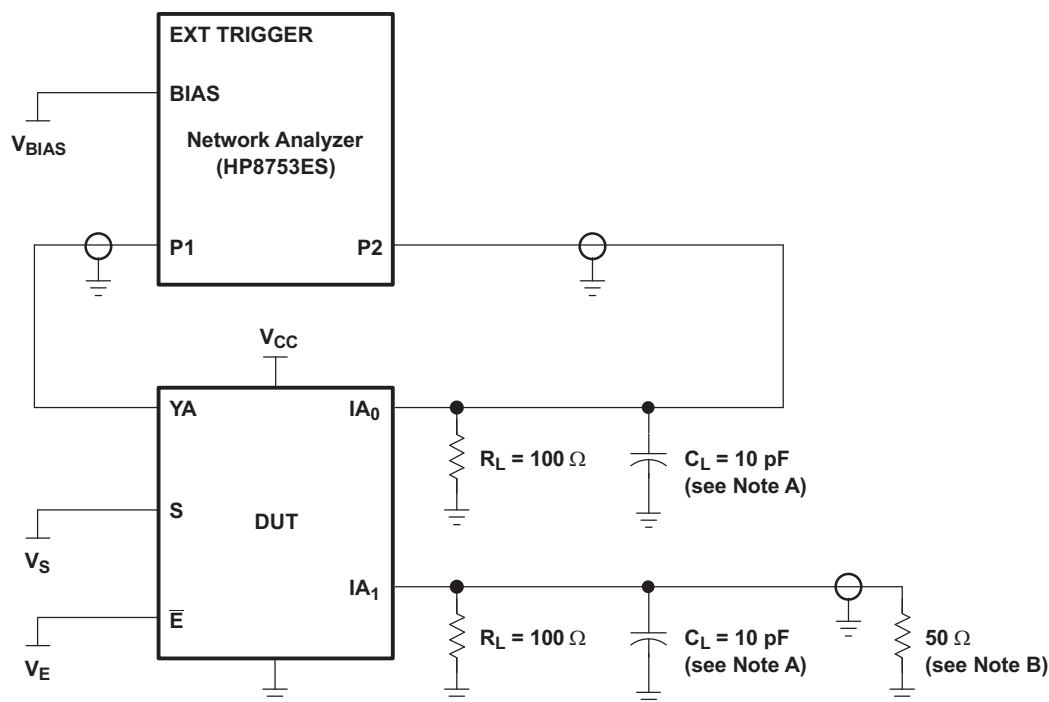
**Figure 8. Test Circuit for Crosstalk ( $X_{TALK}$ )**

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at  $IB_0$ . All unused analog input (Y) ports are connected to GND, and output (I) ports are connected to GND through 50- $\Omega$  pulldown resistors.

#### HP8753ES Setup

- Average = 4
- RBW = 3 kHz
- $V_{BIAS} = 0.35$  V
- ST = 2 s
- P1 = 0 dBm

### Parameter Measurement Information (continued)



A.  $C_L$  includes probe and jig capacitance.

B. A 50- $\Omega$  termination resistor is needed to match the loading of the network analyzer

**Figure 9. Test Circuit for OFF Isolation ( $O_{IRR}$ )**

OFF isolation is measured at the output of the OFF channel. For example, when  $V_S = V_{CC}$ ,  $V_E = 0$ , and YA is the input, the output is measured at  $IA_0$ . All unused analog input (Y) ports are left open, and output (I) ports are connected to GND through 50- $\Omega$  pulldown resistors.

#### HP8753FS Setup

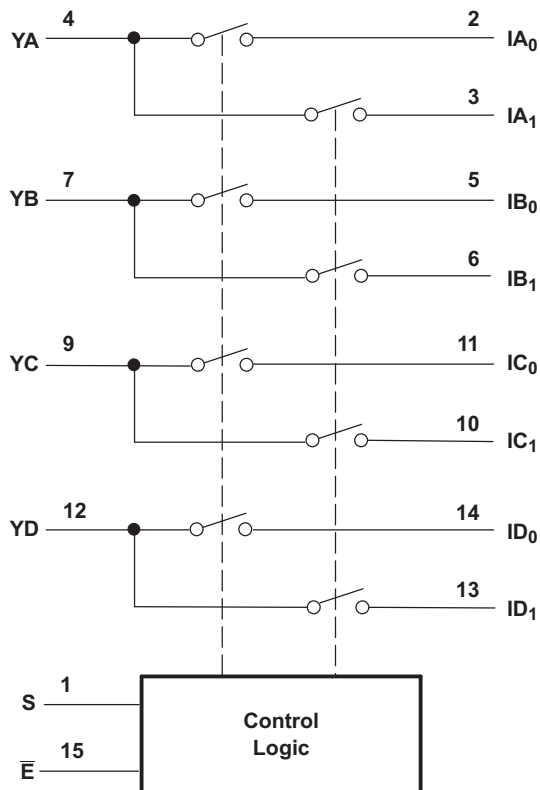
- Average = 4
- RBW = 3 kHz
- $V_{BIAS} = 0.35\text{ V}$
- ST = 2 s
- P1 = 0 dBm

## 8 Detailed Description

### 8.1 Overview

The TI TS3L110 LAN switch is a 4-bit 1-of-2 multiplexer/demultiplexer with a single switch-enable (E) input. When E is low, the switch is enabled, and the I port is connected to the Y port. When E is high, the switch is disabled, and the high-impedance state exists between the I and Y ports. The select (S) input controls the data path of the multiplexer/demultiplexer.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

$I_{off}$  supports Partial-Power-Down Mode Operation.

The TS3L110 device ensures the signal path is high impedance state when  $V_{CC} = 0$  V.

### 8.4 Device Functional Modes

The TS3L110 supports a power down mode which reduces the current consumption of the device and places all the signal paths in a high impedance state. To place the TS3L100 in power down mode, set the  $\overline{E}$  pin with a logic high voltage as seen in Table 1.

**Table 1. Function Table**

INPUTS		INPUT/OUTPUT YX	FUNCTION
$\overline{E}$	S		
L	L	$IX_0$	$YX = IX_0$
L	H	$IX_1$	$YX = IX_1$
H	X	Z	Disconnect

## 9 Application and Implementation

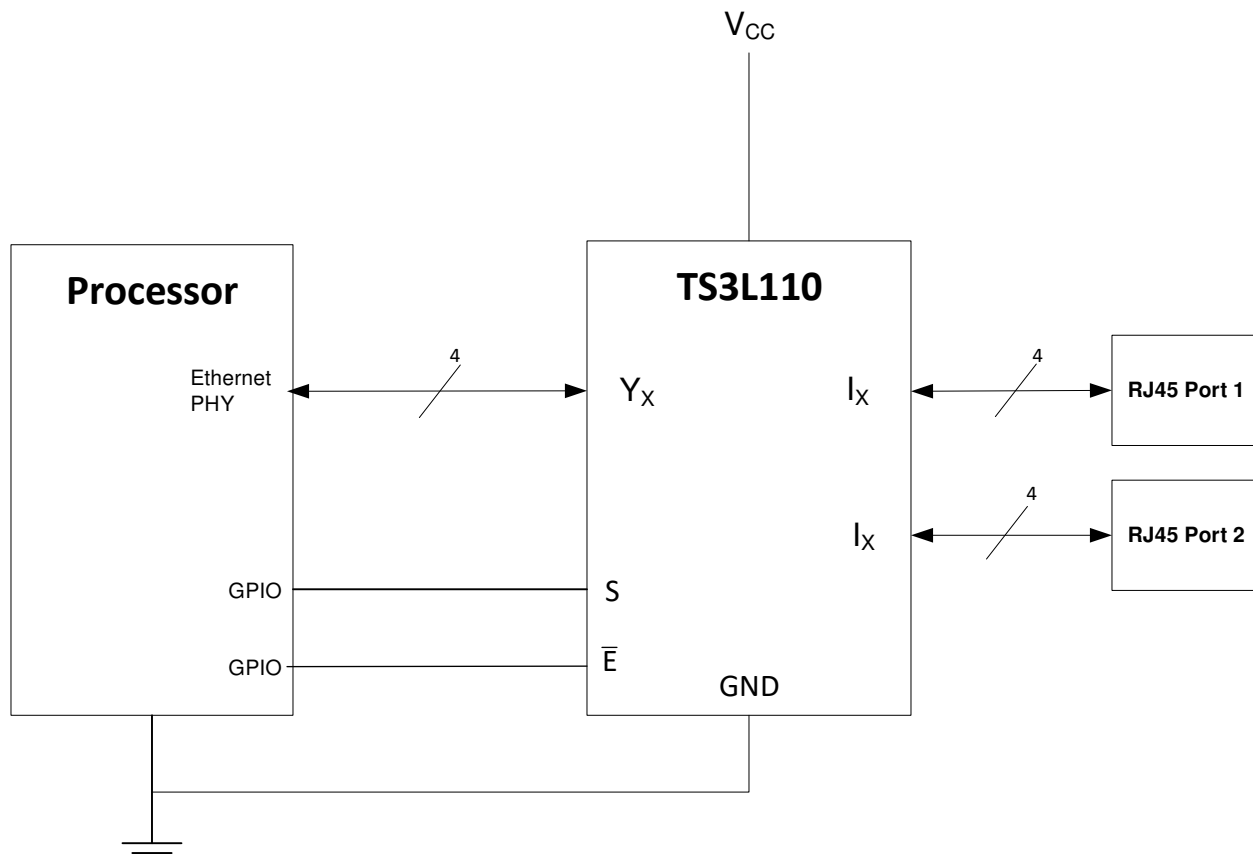
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

There are many Local Area Network (LAN) applications in which the ethernet hubs or controllers have a limited number of I/Os or need to route signals from a single ethernet PHY to multiple ethernet jacks. The TS3L110 solution can effectively expand the limited I/Os by switching between multiple Ethernet jacks to interface them to a single Ethernet PHY.

### 9.2 Typical Application



**Figure 10. Typical Application Schematic**

#### 9.2.1 Design Requirements

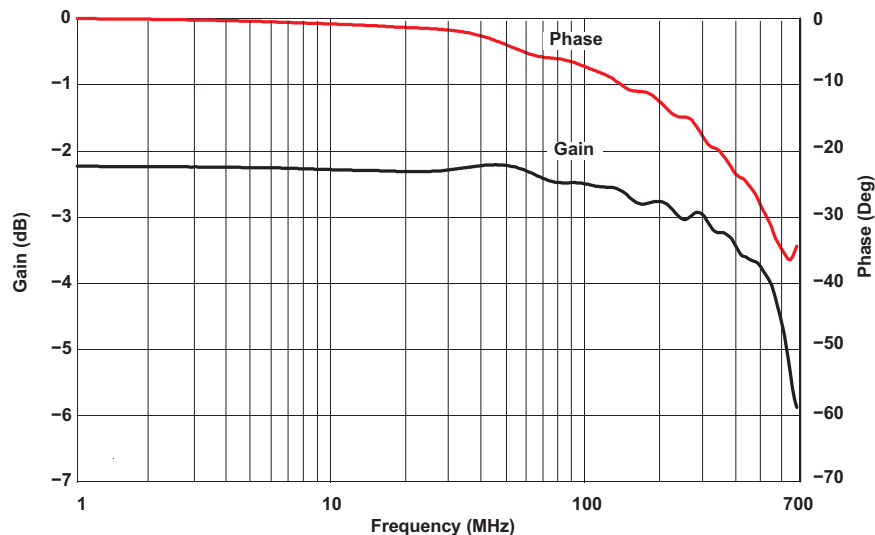
Ensure that all of the signals passing through the switch are within the recommended operating ranges. To ensure proper performance, see Recommended Operating Conditions.

#### 9.2.2 Detailed Design Procedure

The TS3L110 can be properly operated without any external components. TI recommends that the digital control pins S and  $\bar{E}$  be pulled up to VCC or down to GND to avoid undesired switch positions that could result from the floating pin. Connect the exposed thermal pad to ground.

## Typical Application (continued)

### 9.2.3 Application Curves



Phase at 627 MHz, -36 Deg

Gain -3 dB at 627 MHz

**Figure 11. Gain and Phase vs Frequency**

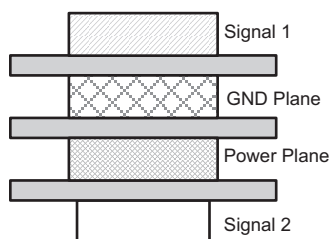
## 10 Power Supply Recommendations

Power to the device is supplied through the VCC pins. TI recommends placing a bypass capacitor as close to the supply pin (VCC) as possible to help smooth out lower frequency noise to provide better load regulation across the frequency spectrum.

## 11 Layout

### 11.1 Layout Guidelines

- TI recommends keeping the high-speed signals as short as possible.
- Each via introduces discontinuities in the transmission line of the signal and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points on twisted pair lines; through-hole pins are not recommended.
- When it becomes necessary to turn 90°, use two 45° turns or an arc instead of making a single 90° turn. This reduces reflections on the signal traces by minimizing impedance discontinuities.
- Do not route traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices or ICs that use or duplicate clock signals.
- Avoid stubs on the high-speed signals because they cause signal reflections. If a stub is unavoidable, then the stub must be less than 200 mm.
- Route all high-speed signal traces over continuous GND planes, with no interruptions. Avoid crossing over anti-etch, commonly found with plane splits.
- Due to high-frequency signals, a printed-circuit board with at least four layers is recommended; two signal layers separated by a ground and power layer as shown in [Figure 12](#).
- The majority of signal traces must run on a single layer, preferably Signal 1. Immediately next to this layer should be the GND plane, which is solid with no cuts. Avoid running signal traces across a split in the ground or power plane. When running across split planes is unavoidable, sufficient decoupling must be used. Minimizing the number of signal vias reduces EMI by reducing inductance at high frequencies.



**Figure 12. Four-Layer Board Stackup**



## 11.2 Layout Example

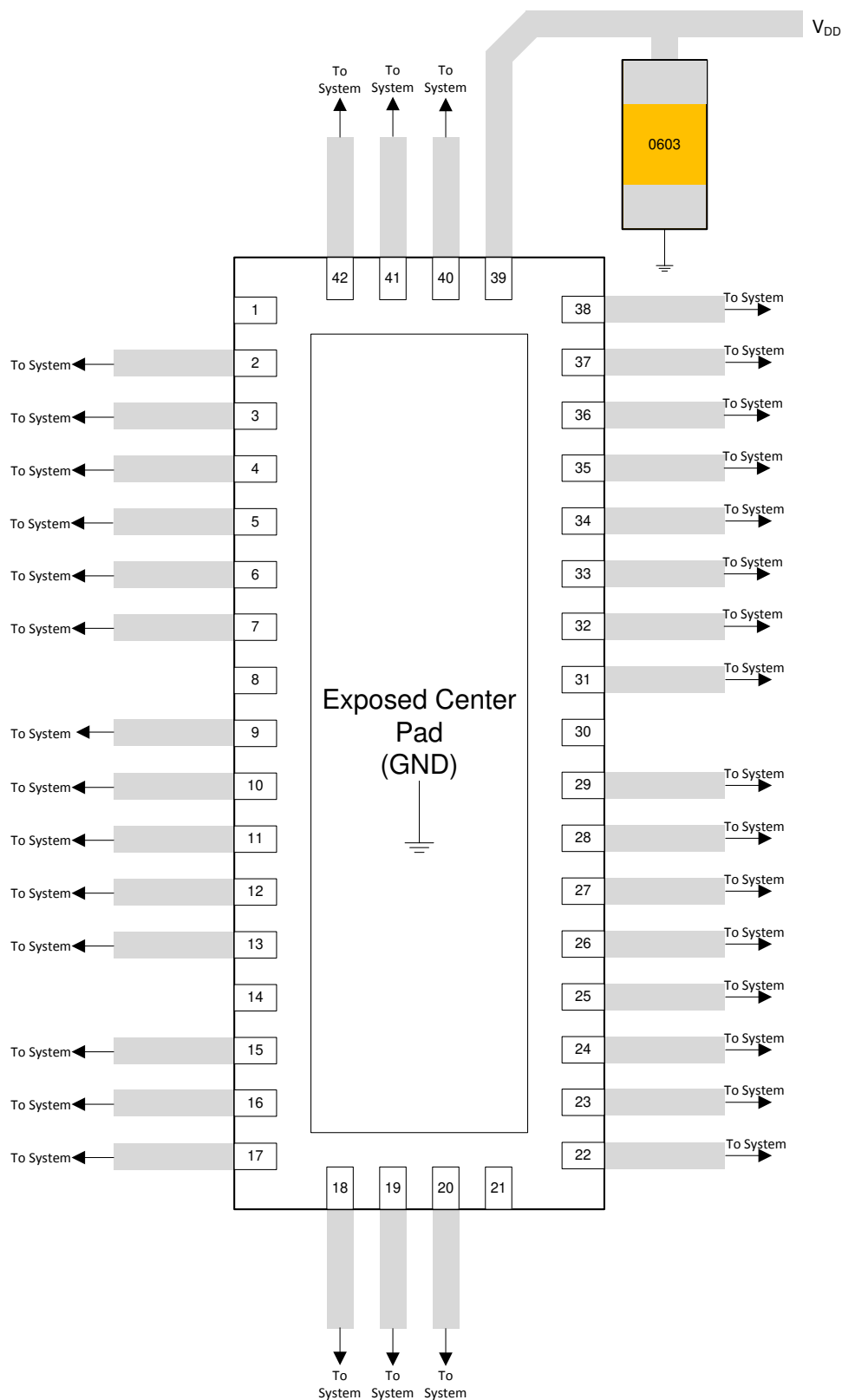


Figure 13. Layout Example

## 12 Device and Documentation Support

### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.2 Community Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 12.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 12.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TS3L110D</a>	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3L110
TS3L110D.B	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3L110
<a href="#">TS3L110DBQR</a>	Active	Production	SSOP (DBQ)   16	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110DBQR.B	Active	Production	SSOP (DBQ)   16	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110DBQRG4	Active	Production	SSOP (DBQ)   16	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110DBQRG4.B	Active	Production	SSOP (DBQ)   16	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110DE4	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3L110
TS3L110DG4	Active	Production	SOIC (D)   16	40   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3L110
<a href="#">TS3L110DGVR</a>	Active	Production	TVSOP (DGV)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TK110
TS3L110DGVR.B	Active	Production	TVSOP (DGV)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TK110
<a href="#">TS3L110DR</a>	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3L110
TS3L110DR.B	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3L110
<a href="#">TS3L110PW</a>	Obsolete	Production	TSSOP (PW)   16	-	-	Call TI	Call TI	-40 to 85	TK110
<a href="#">TS3L110PWR</a>	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TK110
TS3L110PWR.B	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TK110
<a href="#">TS3L110RGYR</a>	Active	Production	VQFN (RGY)   16	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110RGYR.B	Active	Production	VQFN (RGY)   16	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110RGYRG4	Active	Production	VQFN (RGY)   16	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110
TS3L110RGYRG4.B	Active	Production	VQFN (RGY)   16	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TK110

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3L110DBQR	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TS3L110DBQRG4	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TS3L110DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
TS3L110DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS3L110PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TS3L110RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
TS3L110RGYRG4	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3L110DBQR	SSOP	DBQ	16	2500	353.0	353.0	32.0
TS3L110DBQRG4	SSOP	DBQ	16	2500	353.0	353.0	32.0
TS3L110DGVR	TVSOP	DGV	16	2000	353.0	353.0	32.0
TS3L110DR	SOIC	D	16	2500	340.5	336.1	32.0
TS3L110PWR	TSSOP	PW	16	2000	353.0	353.0	32.0
TS3L110RGYR	VQFN	RGY	16	3000	353.0	353.0	32.0
TS3L110RGYRG4	VQFN	RGY	16	3000	353.0	353.0	32.0

## TUBE



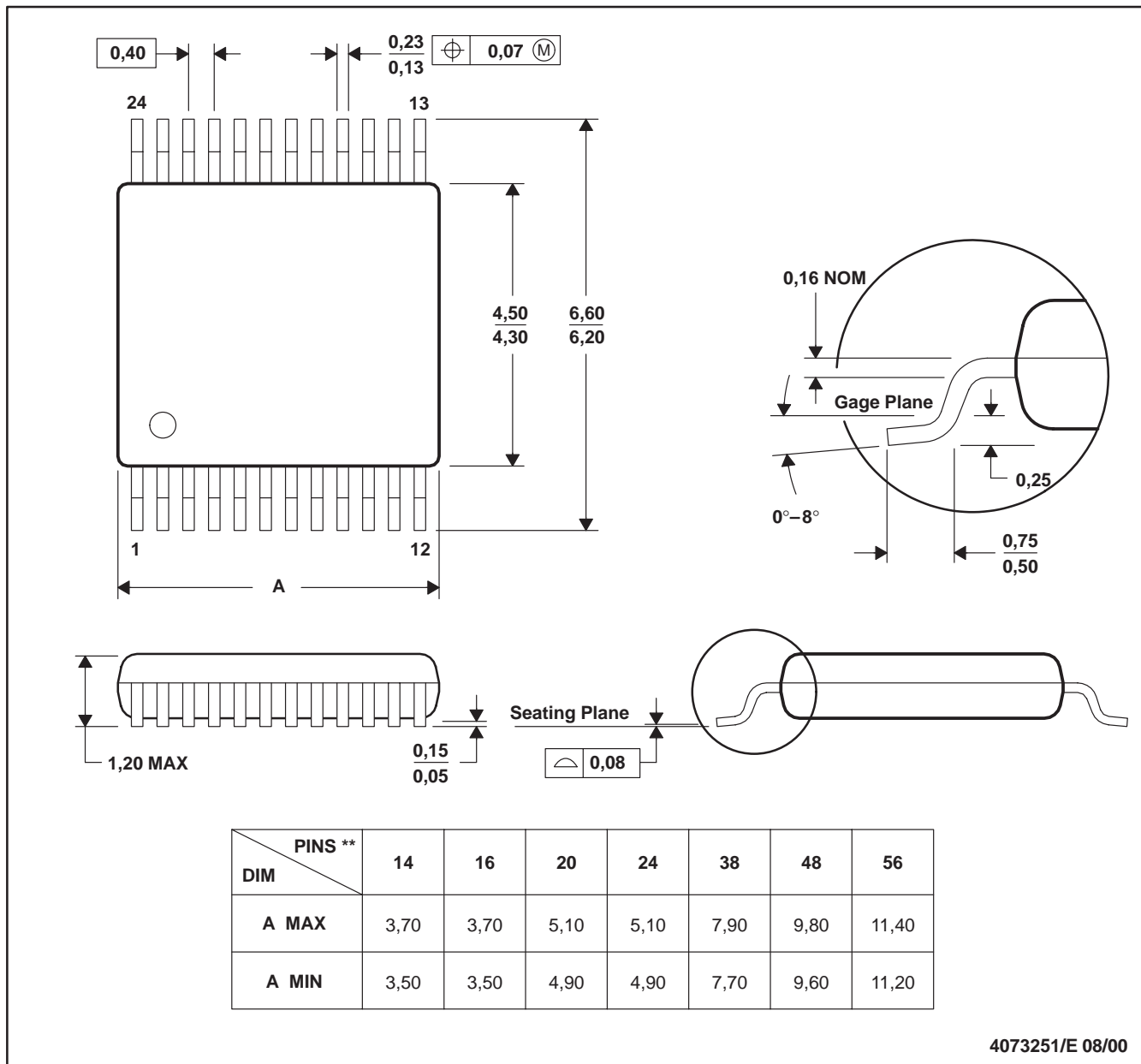
\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
TS3L110D	D	SOIC	16	40	507	8	3940	4.32
TS3L110D.B	D	SOIC	16	40	507	8	3940	4.32
TS3L110DE4	D	SOIC	16	40	507	8	3940	4.32
TS3L110DG4	D	SOIC	16	40	507	8	3940	4.32

## DGV (R-PDSO-G\*\*)

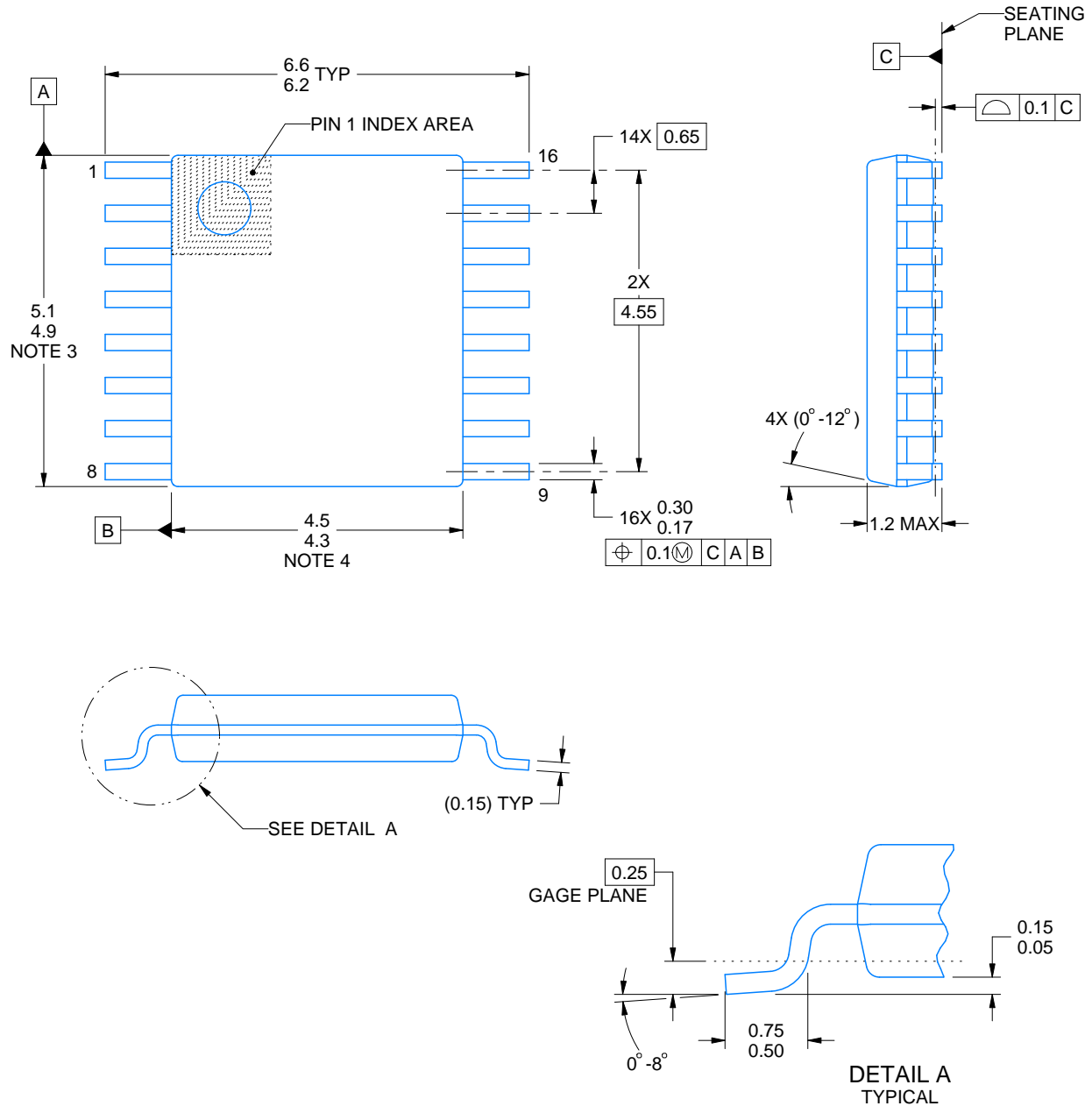
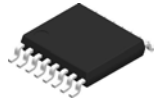
## PLASTIC SMALL-OUTLINE

24 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.  
 D. Falls within JEDEC: 24/48 Pins – MO-153  
 14/16/20/56 Pins – MO-194





4220204/B 12/2023

## NOTES:

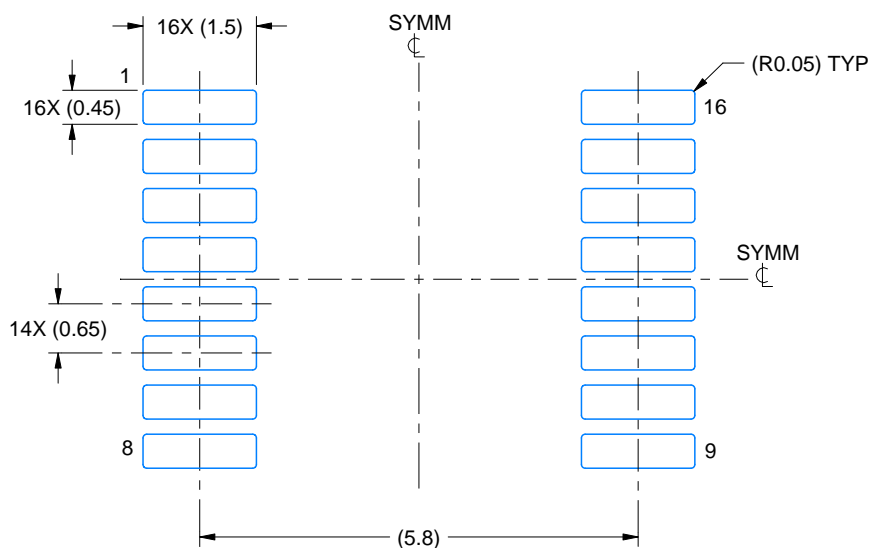
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

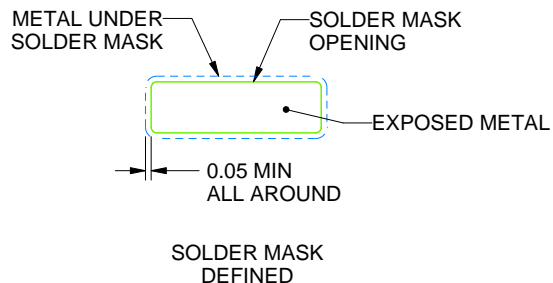
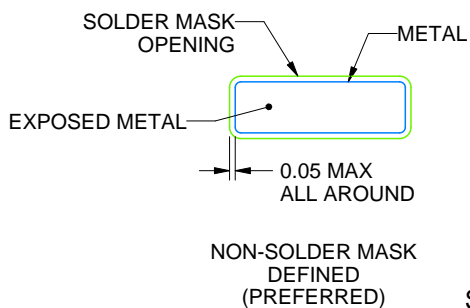
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



SOLDER MASK DETAILS

4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

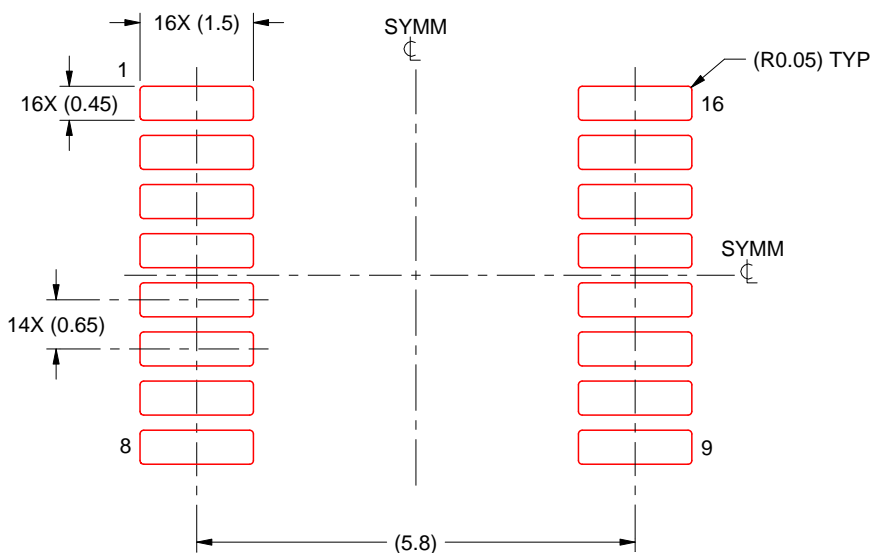
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

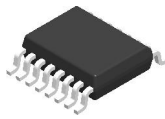


SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

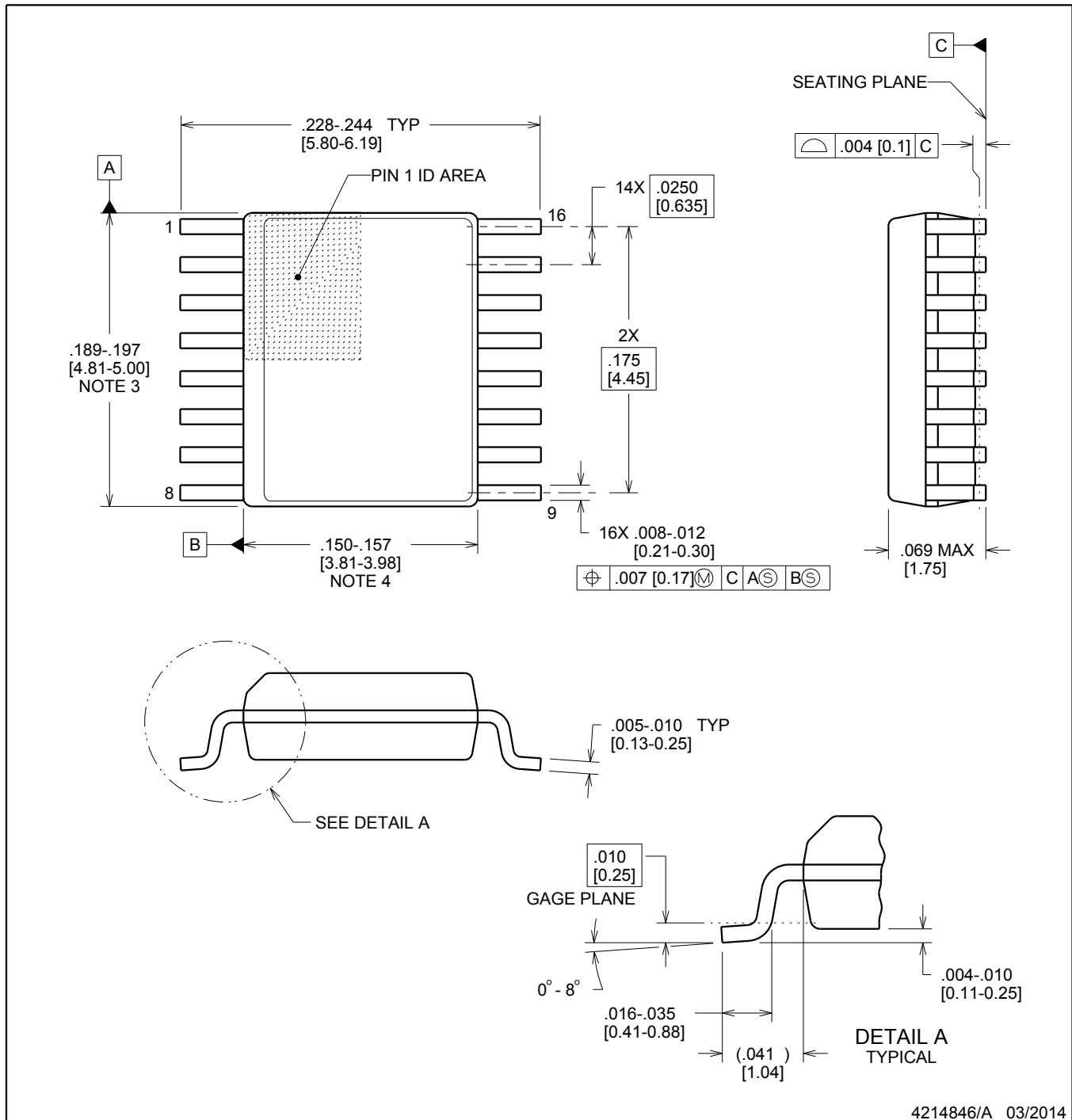


**DBQ0016A**

# PACKAGE OUTLINE

**SSOP - 1.75 mm max height**

SHRINK SMALL-OUTLINE PACKAGE



4214846/A 03/2014

## NOTES:

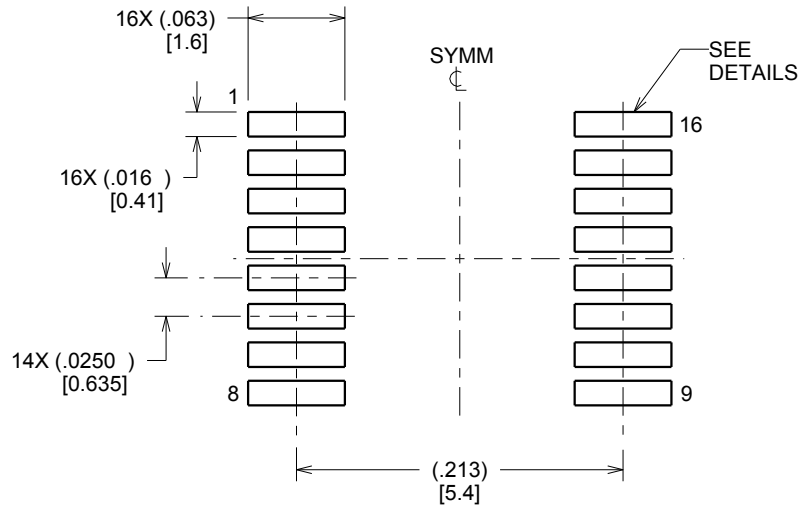
1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MO-137, variation AB.

# EXAMPLE BOARD LAYOUT

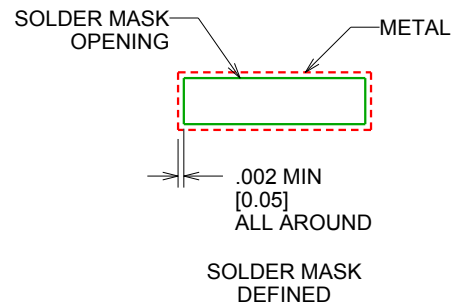
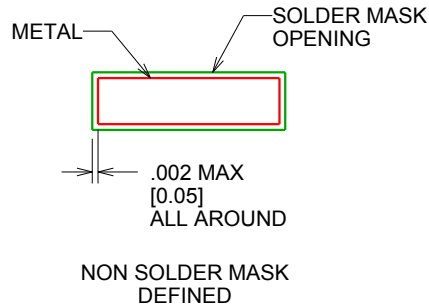
DBQ0016A

SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
SCALE:8X



SOLDER MASK DETAILS

4214846/A 03/2014

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

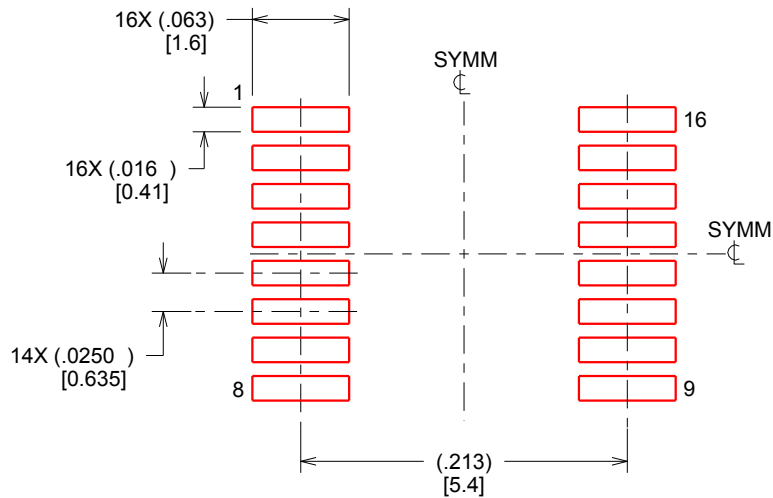
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBQ0016A

SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.127 MM] THICK STENCIL  
SCALE:8X

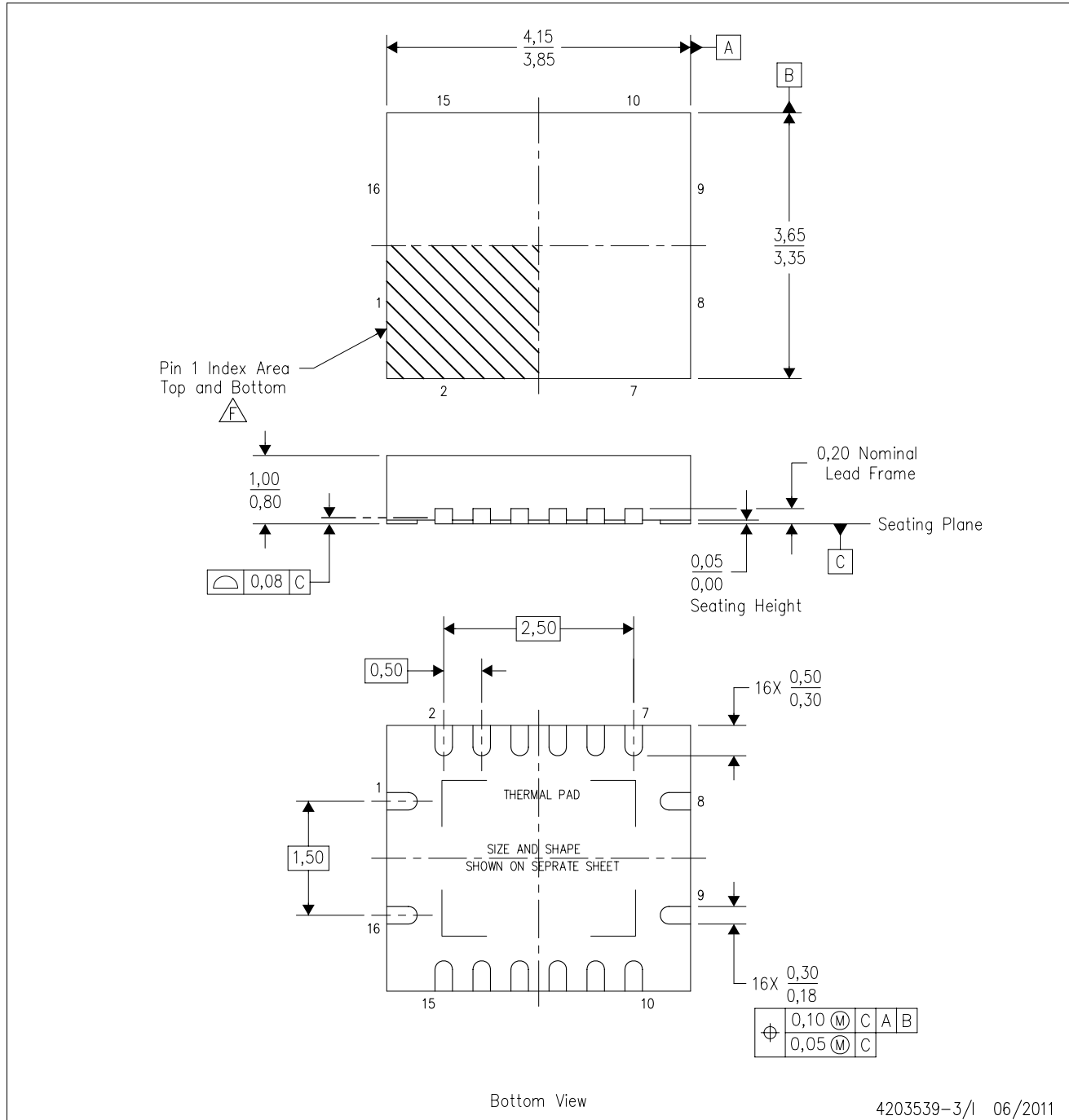
4214846/A 03/2014

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



4203539-3/I 06/2011

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - This drawing is subject to change without notice.
  - QFN (Quad Flatpack No-Lead) package configuration.
  - The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F** Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- Package complies to JEDEC MO-241 variation BA.

RGY (R-PVQFN-N16)

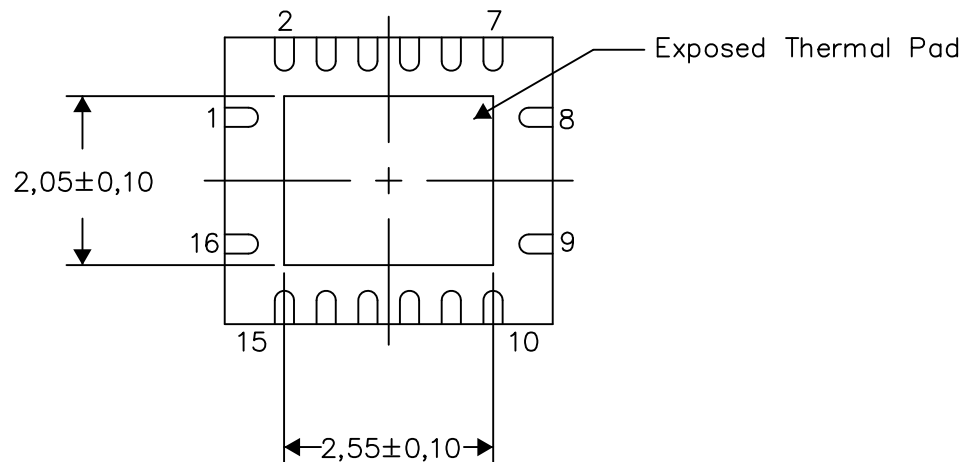
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

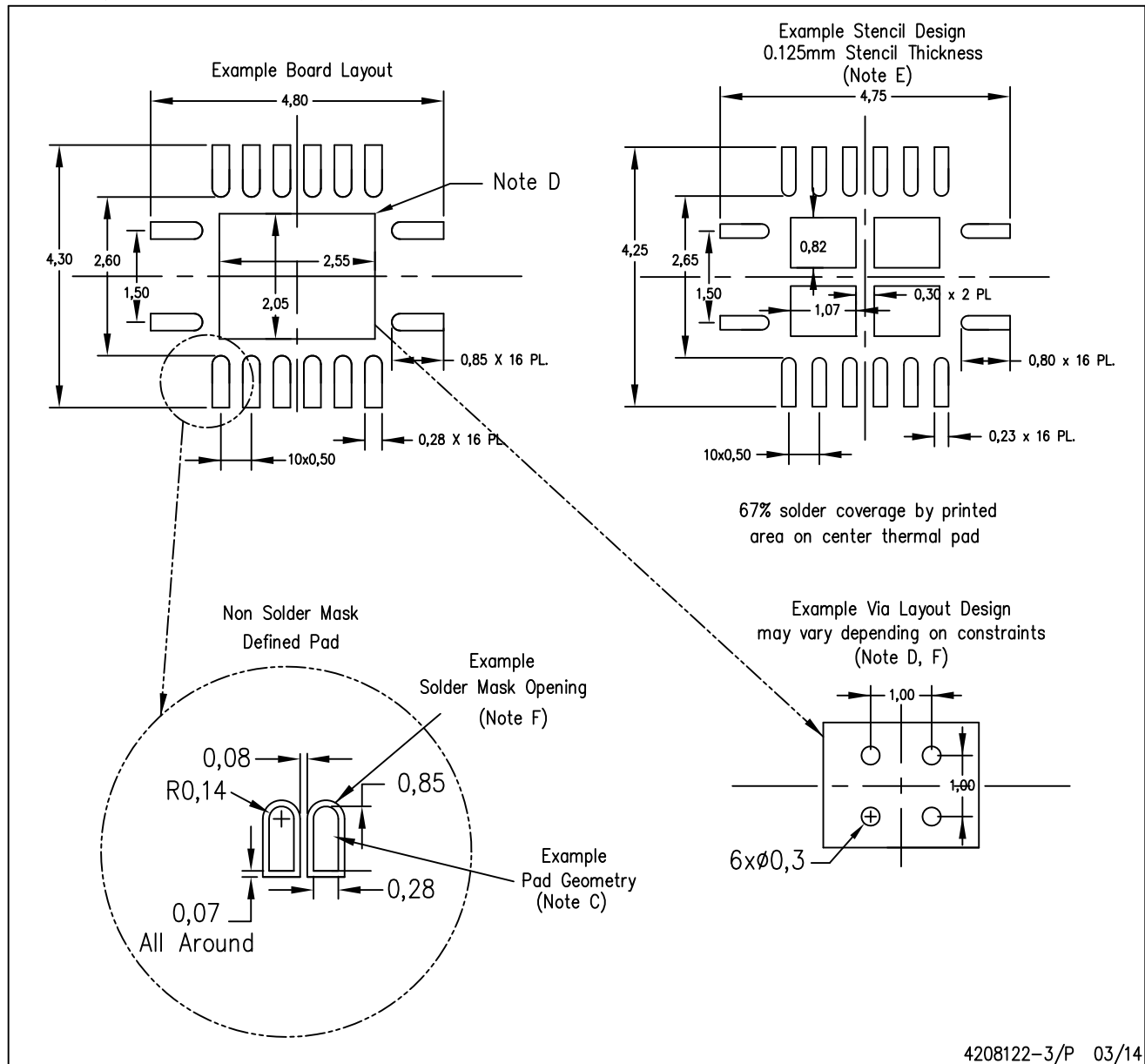
4206353-3/P 03/14

NOTE: All linear dimensions are in millimeters



RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD

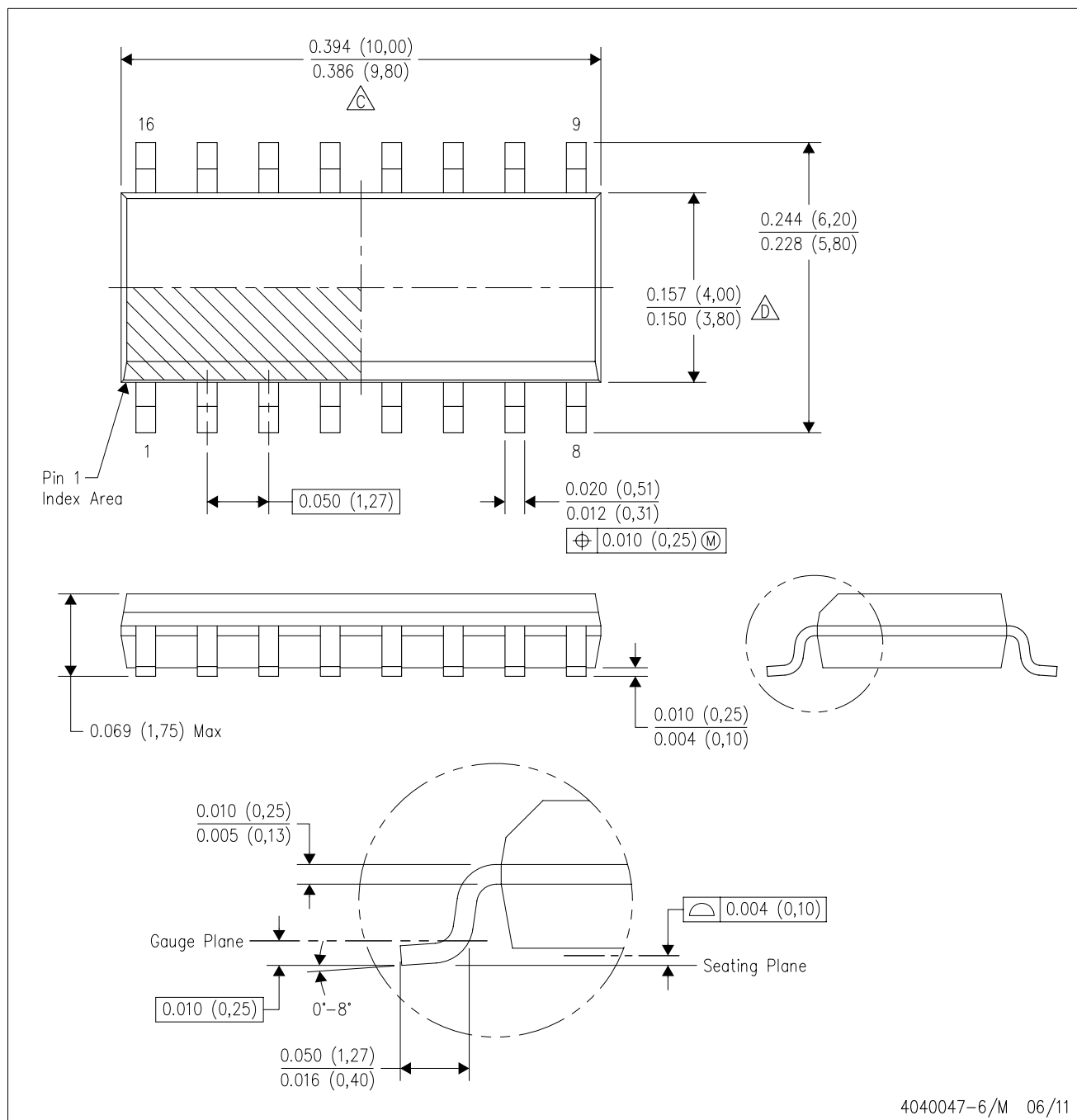


4208122-3/P 03/14

- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



## NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.

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